

# MOS FIELD EFFECT TRANSISTOR

**2SJ493** 

# SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

#### **DESCRIPTION**

This product is P-Channel MOS Field Effect Transistor designed for high current switching applications.

#### ORDERING INFORMATION

| PART NUMBER | PACKAGE         |  |  |
|-------------|-----------------|--|--|
| 2SJ493      | Isolated TO-220 |  |  |

#### **FEATURES**

• Super low on-state resistance

 $R_{DS(on)1}$  = 100  $m\Omega$  (MAX.) (Vgs = –10 V, Ip = –8 A)

 $R_{DS(on)2} = 185 \text{ m}\Omega \text{ (MAX.) (Vgs} = -4 \text{ V, Ip} = -8 \text{ A)}$ 

- Low Ciss: Ciss = 1210 pF (TYP.)
- Built-in gate protection diode

#### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25$ °C)

| Drain to Source Voltage (Vgs = 0 V)             | VDSS     | -60         | V  |
|---|----------|-------------|----|
| Gate to Source Voltage (Vps = 0 V)              | VGSS(AC) | ∓ 20        | V  |
| Gate to Source Voltage (Vps = 0 V) Note1        | VGSS(DC) | -20, 0      | V  |
| Drain Current (DC)                              | ID(DC)   | ∓ 16        | Α  |
| Drain Current (pulse) Note2                     | D(pulse) | ∓ 64        | Α  |
| Total Power Dissipation (Tc = 25°C)             | Рт       | 30          | W  |
| Total Power Dissipation (T <sub>A</sub> = 25°C) | Рт       | 2.0         | W  |
| Channel Temperature                             | Tch      | 150         | °C |
| Storage Temperature                             | Tstg     | -55 to +150 | °C |
| Single Avalanche Current Note3                  | las      | -16         | Α  |
| Single Avalanche Energy Note3                   | Eas      | 25.6        | mJ |

**Notes 1.** f = 20 kHz, Duty Cycle  $\leq 10\%$  (+Side)

- **2.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1 %
- 3. Starting T<sub>ch</sub> = 25 °C, R<sub>A</sub> =  $25\Omega$ , V<sub>GS</sub> = -20 V  $\rightarrow$  0

#### THERMAL RESISTANCE

| Channel to Case    | Rth(ch-C) |      | °C/W |  |
|--------------------|-----------|------|------|--|
| Channel to Ambient | Rth(ch-A) | 62.5 | °C/W |  |

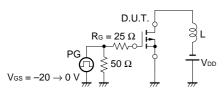
The information in this document is subject to change without notice.

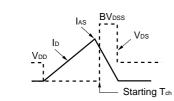


## ELECTRICAL CHARACTERISTICS (TA = 25 °C)

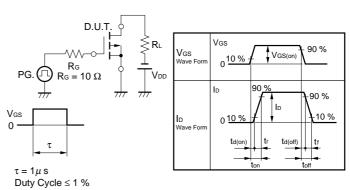
| CHARACTERISTICS                     | SYMBOL               | TEST CONDITIONS                                    | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|--|------|------|------|------|
| Drain to Source On-state Resistance | RDS(on)1             | Vgs = -10 V, ID = -8 A                             |      | 70   | 100  | mΩ   |
|                                     | RDS(on)2             | Vgs = -4 V, ID = -8 A                              |      | 120  | 185  | mΩ   |
| Gate to Source Cut-off Voltage      | V <sub>GS(off)</sub> | $V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$    | -1.0 | -1.5 | -2.0 | V    |
| Forward Transfer Admittance         | yfs                  | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -8 A     | 5.0  | 11   |      | S    |
| Drain Leakage Current               | IDSS                 | V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V     |      |      | -10  | μΑ   |
| Gate to Source Leakage Current      | Igss                 | $V_{GS} = \mp 20  \text{V},  V_{DS} = 0  \text{V}$ |      |      | ∓ 10 | μΑ   |
| Input Capacitance                   | Ciss                 | V <sub>DS</sub> = -10 V                            |      | 1210 |      | pF   |
| Output Capacitance                  | Coss                 | V <sub>G</sub> S = 0 V                             |      | 520  |      | pF   |
| Reverse Transfer Capacitance        | Crss                 | f = 1 MHz  |      | 180  |      | pF   |
| Turn-on Delay Time                  | td(on)               | ID = -8 A  |      | 15   |      | ns   |
| Rise Time                           | tr                   | $V_{GS(on)} = -10 \text{ V}$                       |      | 130  |      | ns   |
| Turn-off Delay Time                 | td(off)              | V <sub>DD</sub> = -30 V                            |      | 95   |      | ns   |
| Fall Time                           | t <sub>f</sub>       | $R_G = 10 \Omega$                                  |      | 80   |      | ns   |
| Total Gate Charge                   | Q <sub>G</sub>       | ID = -16 A   |      | 42   |      | nC   |
| Gate to Source Charge               | Qgs                  | V <sub>DD</sub> = -48 V                            |      | 8.0  |      | nC   |
| Gate to Drain Charge                | Q <sub>GD</sub>      | Vgs = -10 V  |      | 10   |      | nC   |
| Body Diode Forward Voltage          | V <sub>F</sub> (S-D) | IF = 16 A, VGS = 0 V                               |      | 1.0  |      | V    |
| Reverse Recovery Time               | trr                  | IF = 16 A, VGS = 0 V                               |      | 120  |      | ns   |
| Reverse Recovery Charge             | Qrr                  | di/dt = 50 A/μs                                    |      | 230  |      | nC   |

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**





#### **TEST CIRCUIT 2 SWITCHING TIME**

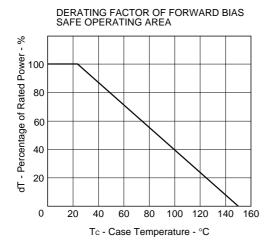


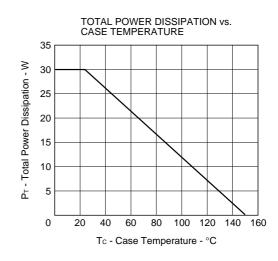
#### **TEST CIRCUIT 3 GATE CHARGE**

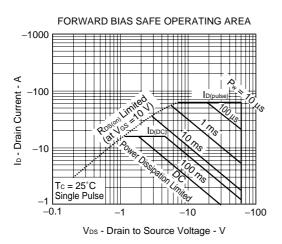
$$\begin{array}{c|c} D.U.T. \\ \hline \\ lG = 2 \text{ mA} \\ \hline \\ PG. \\ \hline \\ \end{array}$$

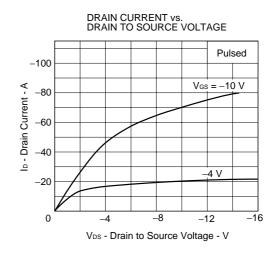


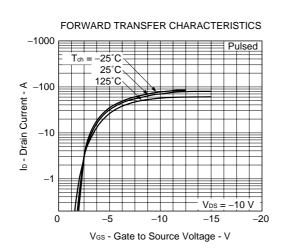
#### TYPICAL CHARACTERISTICS (TA = 25 °C)





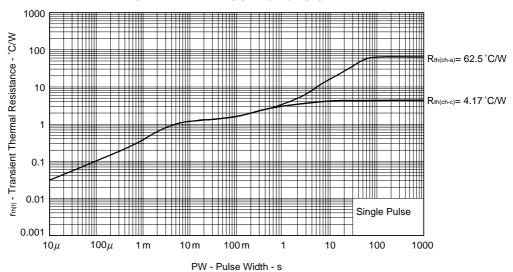


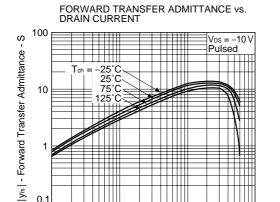




Data Sheet D11265EJ3V0DS00

#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH





-1.0

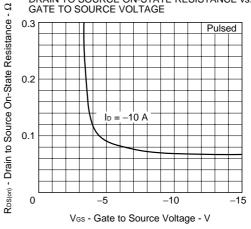
ID - Drain Current - A

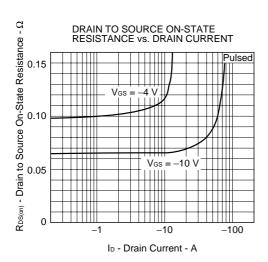
-10

-100

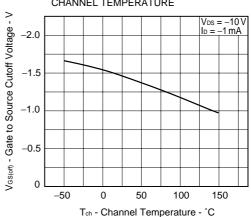
0.1 -0.1



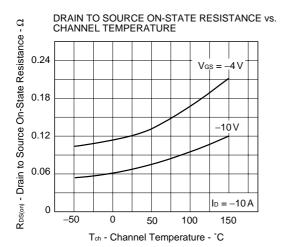


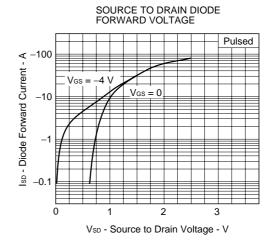


## GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE

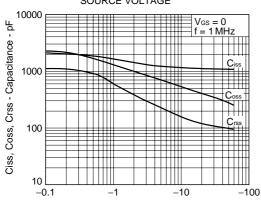


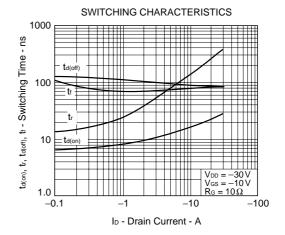






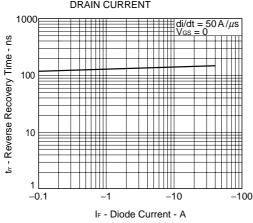
## CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

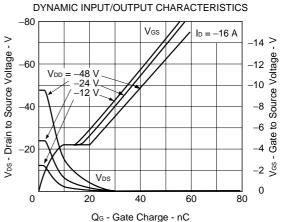


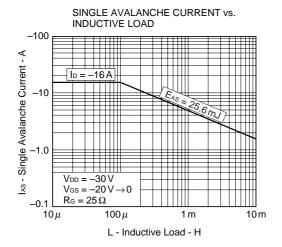


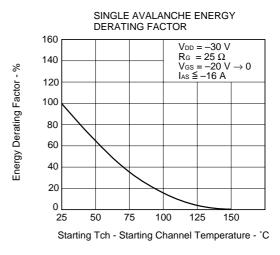
## REVERSE RECOVERY TIME vs. DRAIN CURRENT

V<sub>DS</sub> - Drain to Source Voltage - V





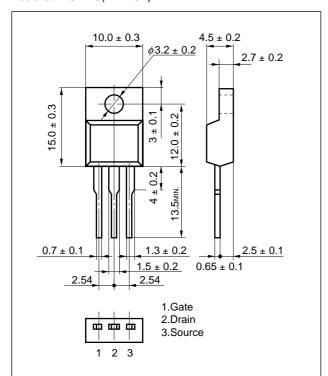




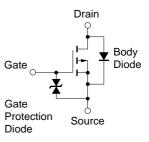


### PACKAGE DRAWING (Unit: mm)

#### Isolated TO-220(MP-45F)



#### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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Anti-radioactive design is not implemented in this product.

M4 96.5